

Search Notes**Application/Control No.**

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Examiner

Alecia D. Nelson

**Applicant(s)/Patent under
Reexamination**

ONISHI ET AL.

Art Unit

2675

SEARCHED

Class	Subclass	Date	Examiner
update	search	1/12/2006	ADN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR